

Devices Connected/Referenced

AD9253

14-Bit, 125 MSPS Quad Channel, Analog-to-Digital Converter

14-Bit, 125 MSPS Quad ADC with SNR Enhanced by Post Digital Summation

EVALUATION AND DESIGN SUPPORT

Design and Integration Files

[Schematics](#), [Layout Files](#), [Bill of Materials](#)

CIRCUIT FUNCTION AND BENEFITS

The circuit shown in Figure 1 is a simplified diagram of a 14-bit, 125 MSPS quad ADC system that uses post digital summation to increase the signal-to-noise ratio (SNR) from 74 dBFS for a single ADC to 78.5 dBFS for the quad ADC with summation.

This technique is especially suitable for applications requiring high SNR such as ultrasound and radar, and makes use of modern high performance low power quad pipelined ADCs.

The circuit makes use of the fundamental principle that uncorrelated noise sources add on a root-sum-square (rss) basis, while signal voltages add on a linear basis.

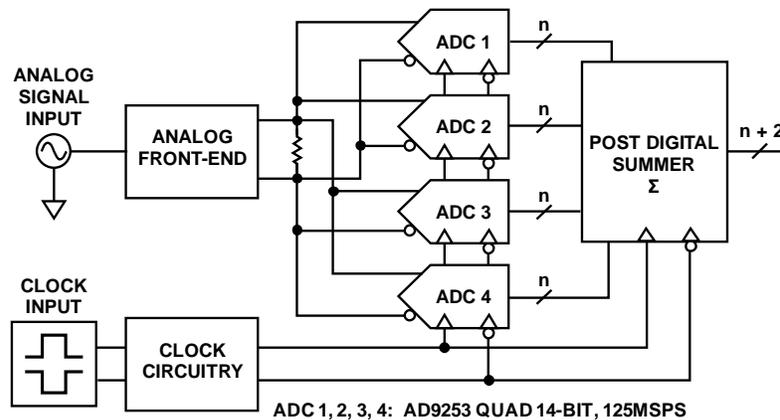


Figure 1. Basic Block Diagram of Summing Four ADC in Parallel to Achieve Higher SNR

Rev. 0

Circuits from the Lab™ circuits from Analog Devices have been designed and built by Analog Devices engineers. Standard engineering practices have been employed in the design and construction of each circuit, and their function and performance have been tested and verified in a lab environment at room temperature. However, you are solely responsible for testing the circuit and determining its suitability and applicability for your use and application. Accordingly, in no event shall Analog Devices be liable for direct, indirect, special, incidental, consequential or punitive damages due to any cause whatsoever connected to the use of any Circuits from the Lab circuits. (Continued on last page)

CIRCUIT DESCRIPTION

The input to each ADC consists of a signal term (V_S) and a noise term (V_N). Summing four noisy voltage sources results in a total voltage, V_T , which is the linear sum of the four signal voltages plus the root-sum-square of the four noise voltages, for example

$$V_T = V_{S1} + V_{S2} + V_{S3} + V_{S4} + \sqrt{V_{N1}^2 + V_{N2}^2 + V_{N3}^2 + V_{N4}^2}$$

Since $V_{S1} = V_{S2} = V_{S3} = V_{S4}$, the signal has effectively been multiplied by four, while the converter noise—with equal rms values—has been multiplied by only two, thereby increasing the signal-to-noise ratio by a factor of two, or 6.02 dB. Thus, the 6.02 dB increase in SNR results from summing four like signals gives rise to one additional bit of effective resolution. Since $SNR(dB) = 6.02N + 1.76$ dB, where N is the number of bits,

$$N + \Delta N = \left[\frac{SNR(dB)}{6.02} - \frac{1.76}{6.02} \right] + \frac{6.02 \text{ dB}}{6.02} = N + 1$$

Table 1 shows the theoretical SNR that results from summing the outputs of multiple ADCs. From the standpoint of simplicity, summing four ADCs is an obvious choice. Larger numbers may also be of interest in critical cases, but that would depend on other system specifications (including cost) and the amount of board space available.

Table 1. Increase in SNR vs. Number of ADCs

Number of ADCs	Increase in SNR (dB)
2	3
4	6
8	9
16	12
32	15

The ideal SNR for a 14-bit ADC is $(6.02 \times 14) + 1.76 = 86.04$ dB. The [AD9253](#) data sheet specifies a typical SNR of 74 dB, however, yielding an ENOB of 12 bits.

$$ENOB = \frac{74 - 1.76}{6.02} = 12 \text{ bits}$$

The circuit shown in Figure 1 has a passive receiver front end that combines four analog input channels together, based on the [AD9253](#) 14-bit, 125 MSPS quad channel, analog-to-digital converter.

The circuit accepts a single-ended input and converts it to differential using two wide bandwidth (3 GHz) M/A-COM ETC1-1-13 1:1 impedance ratio balun in a double balanced configuration as shown in Figure 2.

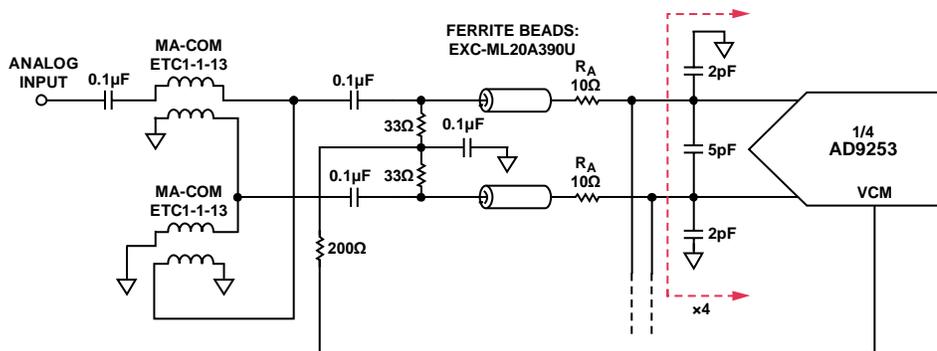


Figure 2. Input Analog Summation Network

10903-002

All four ADC inputs are connected together at the secondary of the balun configuration. No gain is applied in the circuit, and there is simple filtering at each analog input pair to reduce the amount of residual kickback that could potentially feedback into adjacent ADC channels.

The fully differential architecture through the ADC provides good high frequency common-mode rejection so that uncorrelated noise sources are minimized when summed yielding a performance of 78.5 dBFS SNR and 85dBc SFDR in the first Nyquist band (0 MHz to 62.5 MHz when sampling at 125 MSPS). The overall circuit has a bandwidth of 65 MHz with a pass band flatness of 1 dB.

To achieve best performance, a double-balanced balun approach was used to achieve the best even order spurious performance over frequency. Because the inputs of four ADCs were connected together, maintaining balance can be a challenge even at frequencies less than 100 MHz.

A 66 Ω differential termination was used to terminate the secondary of the balun configuration. The value of 66 Ω was chosen to help reduce the loss of the parallel combination of the four converter input impedances and minimize the loss seen from the secondary to the primary of the transformer, yielding an overall impedance of approximately 50 Ω, as seen from the primary.

Ferrite beads were employed in this design to help reduce the effects of parasitic capacitive loads from the board layout as well as the parallel combination of the four unbuffered ADC channels. The beads reduce the kickback from each of the ADC input channels thus preserving overall bandwidth.

The 10 Ω series resistors serve a dual purpose. First, they drive the ADC input filters (2 pF common-mode and 5 pF differential), second, they serve to reduce the amount of kickback that comes from each ADC. For more information on charge kickback and unbuffered ADC architectures, see Application Note AN-742.

The measured performance of the system is summarized in Table 2, where the -3 dB bandwidth is 67 MHz. The total insertion loss of the network is approximately 3 dB, therefore an input drive of +13 dBm is needed to provide a full-scale 2 V p-p differential signal to the input of the ADCs.

Table 2. Measured Performance of the Circuit

Performance Specs at 2.0 V p-p FS	Final Results
Sample Frequency	125 MSPS
Pass-Band Flatness (67 MHz)	3 dB
SNRFs at 10 MHz	78.5 dBFS
SFDR at 10 MHz	85 dBc
H2/H3 at 10 MHz	85 dBc/90 dBc
Input Impedance at 10 MHz	58 Ω
Input Drive at 10 MHz	+13.0 dBm

System Performance

The AD9253 14-bit, 125 MSPS quad ADC is pin-compatible with the AD9653 16-bit, 125 MSPS ADC. Bandwidth was measured for the quad summation configurations of the AD9253 and AD9653 for comparison and is shown in Figure 3.

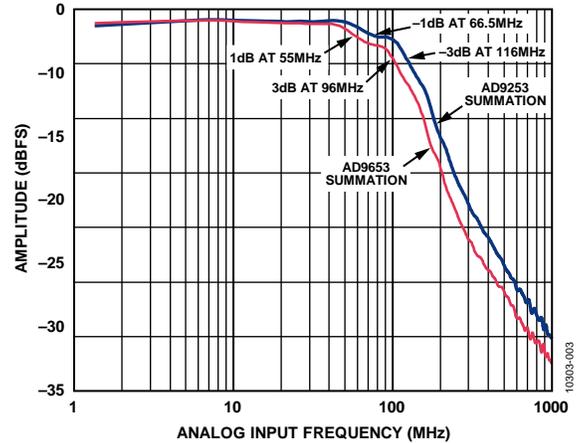


Figure 3. Frequency Response for Quad Summation Configurations of the AD9253 and AD9653

SNR was measured for both the single and quad versions of the AD9253 and AD9653 and is shown in Figure 4.

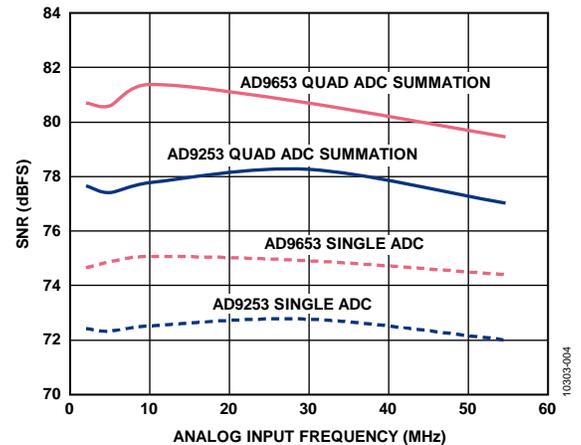


Figure 4. SNR Performance vs. Frequency for Single and Quad Summation Configurations of the AD9253 and AD9653

Note that the use of the quad summation technique increases the SNR of the AD9253 14-bit ADC at 10 MHz by approximately 5 dB. The SNR of the AD9653 16-bit ADC is increased by approximately the same amount.

On the other hand, the difference between the single AD9253 14-bit ADC and the single AD9653 16-bit ADC is approximately 3 dB. SFDR data was taken for the quad summation configuration of the AD9253 and AD9653, and it is shown in Figure 5.

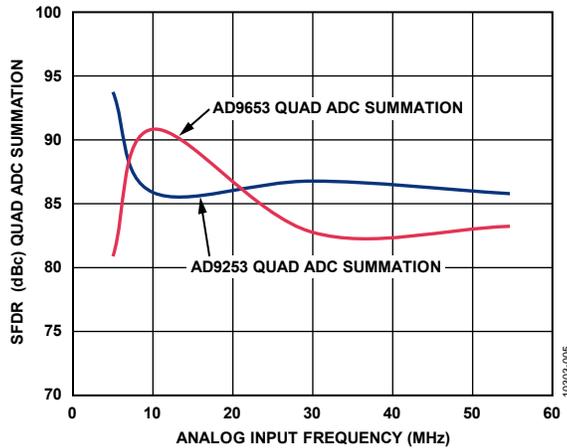


Figure 5. SFDR Performance vs. Frequency for Quad Summation Configurations of the AD9253 and AD9653

The input impedance of the circuit shown in Figure 1 and Figure 2 was measured using a network analyzer calibrated to $50\ \Omega$ over a 1 GHz band, as shown in Figure 6. The final network was found to have a VSWR of 1.2 or less over the desired band (1st Nyquist zone, dc to 62.5 MHz).

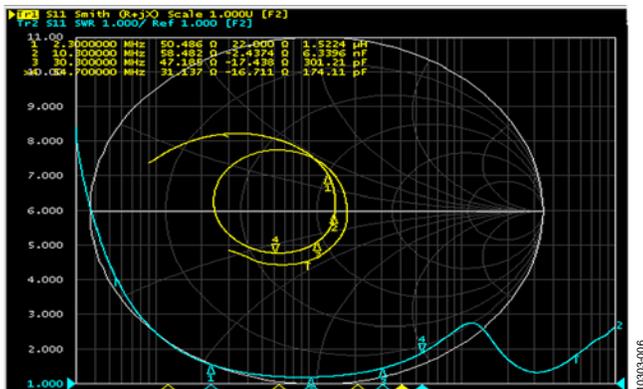


Figure 6. Input Impedance of Complete Frontend Four-Channel Summation

Front End Interface Design Procedure

In this section, a general approach to the design of the passive front end ADC interface with filter is presented for the passive summation technique. To achieve optimum performance (bandwidth, SNR, and SFDR), there are certain design constraints placed on the general circuit by the front end and the ADC:

- Know and understand the key parameters in designing a front end. These include the following:
 - Input impedance/VSWR or voltage standing wave ratio, is a unitless parameter that shows how much power is being reflected into the load over the bandwidth of interest. Input impedance of the network is the specified value of the load, usually $50\ \Omega$.
 - Passband flatness is usually defined as the amount of fluctuation ripple that can be tolerated within the specified bandwidth.
 - Bandwidth is simply the range of the frequencies to be used in the system.

- Minimum SNR (signal-to-noise ratio) and SFDR (spurious free dynamic range)
- Input drive level is a function of the bandwidth, input impedance, and VSWR specifications. This sets the gain and amplitude required for a full-scale input signal at the converter. It is highly dependent on the front-end components chosen, for example, the transformer, amplifier, or anti-aliasing filter, and can be one of the most difficult parameters to achieve.
- The correct amount of series resistance between the ADC and the load presented by the filter must be determined. This is to prevent undesired peaking in the pass band and minimize the kickback from the individual ADC inputs. In most cases, the correct value must be determined empirically.
- The input impedance of the ADC may need to be lowered by shunting it with an external parallel resistor.
- The correct series resistance should be used to isolate the ADC from the filter. This series resistor also reduces peaking and is usually determined empirically.

Circuit Optimization Techniques and Trade-Offs

The parameters in the interface circuit are very interactive; therefore, it is almost impossible to optimize the circuit for all key specifications (bandwidth, bandwidth flatness, SNR, SFDR, and gain).

In Figure 2, the pass-band peaking can be reduced as the value of the series resistance, R_A , is increased. However, as the value of this resistance increases, there is more signal attenuation, and the input network must be driven with a larger signal to fill the parallel combination of all ADCs full-scale input range.

Balancing these trade-offs can be somewhat difficult. In this design, each parameter was given equal weight; therefore, the values chosen are representative of the interface performance for all the design characteristics. In some designs, different values may be chosen to optimize SFDR, SNR, or input drive level, depending on system requirements.

The SNR performance in this design is determined by several factors: the nature of the ADC architecture and the setting of the internal front-end buffer bias current in the AD9253 via the internal sample and hold mechanisms as well as the bandwidth required for the design. In this case, the entire first Nyquist was used.

Another trade-off that can be made in this particular design is the ADC full-scale setting. The full-scale ADC differential input voltage was set for 2 V p-p for the data obtained with this design, which optimizes SFDR. Changing the full-scale input range to lower than the maximum full scale of 2.0 V p-p yields a degradation in SNR performance.

Passive Component and PC Board Parasitic Considerations

The performance of this or any high speed circuit is highly dependent on proper PCB layout. This includes, but is not limited to, power supply bypassing, controlled impedance lines (where required), component placement, signal routing, and power and ground planes. See Tutorials [MT-031](#) and [MT-101](#) for more detailed information regarding PCB layout for high speed ADCs and amplifiers.

Use low parasitic surface-mount capacitors, inductors, and resistors for the passive components in the filter. The inductors chosen are from the Coilcraft 0603CS series. The surface mount capacitors used in the filter are 5%, C0G, 0402-type for stability and accuracy.

See the [CN-0249 Design Support Package](#) for complete documentation on the system.

COMMON VARIATIONS

For applications that require the same bandwidth, lower power and lower performance the [AD9633](#) 12-bit, 125 MSPS quad channel A/D converter can be used. For applications that require the same bandwidth, slightly higher power, and higher performance, the [AD9653](#) 16-bit, 125 MSPS quad channel A/D converter can be used. These devices are pin compatible with the others previously listed.

CIRCUIT EVALUATION AND TEST

This circuit uses a modified [AD9253-125EBZ](#) circuit board and the [HSC-ADC-EVALCZ](#) FPGA-based data capture board. The two boards have mating high speed connectors, allowing for the quick setup and evaluation of the circuit's performance. The modified [AD9253-125EBZ](#) board contains the circuit evaluated as described in this note, and the [HSC-ADC-EVALCZ](#) data capture board is used in conjunction with Visual Analog evaluation software, as well as the SPI Controller software to properly control the ADC and capture the data. The CN-0249 Design Support package at <http://www.analog.com/CN0249-DesignSupport> contains the schematics, BOM, and layout for the board. [Application Note AN-835](#) contains complete details on how to set up the hardware and software to run the tests described in this circuit note. The user guide, [Evaluating the AD9653/AD9253/AD9633 Analog-to-Digital Converters](#) describes the basic evaluation procedure for the [AD9253](#).

LEARN MORE

[CN-0249 Design Support Package:](#)

<http://www.analog.com/CN0249-DesignSupport>

[AN-742 Application Note, Frequency Domain Response of Switched-Capacitor ADCs, Analog Devices](#)

[Arrants, Alex, Brad Brannon, and Rob Reeder, AN-835 Application Note, *Understanding High Speed ADC Testing and Evaluation*, Analog Devices.](#)

[Evaluating the AD9653/AD9253/AD9633 Analog-to-Digital Converters, User Guide](#)

[MT-031 Tutorial, *Grounding Data Converters and Solving the Mystery of "AGND" and "DGND"*, Analog Devices.](#)

[MT-101 Tutorial, *Decoupling Techniques*, Analog Devices.](#)

[Rarely Asked Questions: *Considerations of High-Speed Converter PCB Design, Part 1: Power and Ground Planes*, November 2010.](#)

[Rarely Asked Questions: *Considerations of High-Speed Converter PCB Design, Part 2: Using Power and Ground Planes to Your Advantage*, February 2011.](#)

[Rarely Asked Questions: *Considerations of High-Speed Converter PCB Design, Part 3: The E-Pad Low Down*, June 2011.](#)

[Reeder, Rob, *Achieve CM Convergence between Amps and ADCs*, Electronic Design, July 2010.](#)

[Reeder, Rob, *Maximize ADC Performance Through Balance And Symmetry*, Electronic Design, November 2010.](#)

[Reeder, Rob & Michael Elliott, *Kick Back at High-Speed Unbuffered ADCs*, Electronic Design, July 2011.](#)

[Reeder, Rob, *Mine These High-Speed ADC Layout Nuggets For Design Gold*, Electronic Design, September 15, 2011.](#)

[Reeder, Rob, Mark Looney and Jim Hand, *Pushing the State of the Art with Multichannel A/D Converters*, Analogue Dialogue, May 2005.](#)

Data Sheets and Evaluation Boards

[AD9253 Data Sheet](#)

[AD9253 Evaluation Board \(AD9253-125EBZ\)](#)

[Standard Data Capture Platform \(HSC-ADC-EVALCZ\)](#)

REVISION HISTORY

5/13—Revision 0: Initial Version

(Continued from first page) Circuits from the Lab circuits are intended only for use with Analog Devices products and are the intellectual property of Analog Devices or its licensors. While you may use the Circuits from the Lab circuits in the design of your product, no other license is granted by implication or otherwise under any patents or other intellectual property by application or use of the Circuits from the Lab circuits. Information furnished by Analog Devices is believed to be accurate and reliable. However, Circuits from the Lab circuits are supplied "as is" and without warranties of any kind, express, implied, or statutory including, but not limited to, any implied warranty of merchantability, noninfringement or fitness for a particular purpose and no responsibility is assumed by Analog Devices for their use, nor for any infringements of patents or other rights of third parties that may result from their use. Analog Devices reserves the right to change any Circuits from the Lab circuits at any time without notice but is under no obligation to do so.

©2013 Analog Devices, Inc. All rights reserved. Trademarks and registered trademarks are the property of their respective owners.
CN10303-0-5/13(0)

